![ANALOG DEVICES]

120 mA, Current Sinking, 10-Bit, I²C DAC
AD5398

FEATURES

120 mA current sink
Available in 8-lead LFCSP package
2-wire (I²C®-compatible) serial interface
10-bit resolution
Integrated current sense resistor
2.7 V to 5.5 V power supply
Guaranteed monotonic over all codes
Power-down to 0.5 µA typical
Internal reference
Ultralow noise preamplifier
Power-down function
Power-on reset

CONSUMER/COMMUNICATIONS APPLICATIONS

Lens autofocus
Image stabilization
Optical zoom
Shutters
Iris/exposure
Neutral density filter NDFs
Lens covers
Camera phones
Digital still cameras
Camera modules
Digital video cameras (DVCs)/camcorders
Camera-enabled devices
Security cameras
Web/PC cameras

INDUSTRIAL APPLICATIONS

Heater control
Fan control
Cooler (Peltier) control
Solenoid control
Valve control
Linear actuator control
Light control
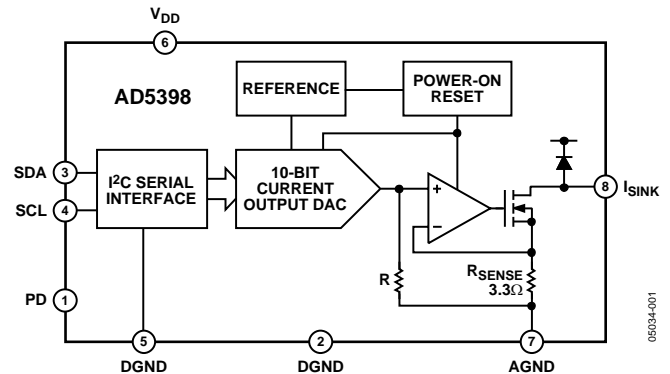**Current loop control**

FUNCTIONAL BLOCK DIAGRAM

Figure 1.

GENERAL DESCRIPTION

The AD5398 is a single 10-bit DAC with 120 mA output current sink capability. It features an internal reference, and operates from a single 2.7 V to 5.5 V supply. The DAC is controlled via a 2-wire (I²C-compatible) serial interface that operates at clock rates up to 400 kHz.

The AD5398 incorporates a power-on reset circuit, which ensures that the DAC output powers up to 0 V and remains there until a valid write takes place. It has a power-down feature that reduces the current consumption of the device to 1 µA max.

The AD5398 is designed for autofocus, image stabilization, and optical zoom applications in camera phones, digital still cameras, and camcorders.

The AD5398 also has many industrial applications, such as controlling temperature, light, and movement, over the range −40°C to +85°C without derating.

The I²C address range for the AD5398 is 0x18 to 0x1F inclusive.

AD5398

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REVISION HISTORY

12/04—Revision 0: Initial Version

SPECIFICATIONS

V_{DD} = 2.7 V to 5.5 V, AGND = DGND = 0 V, load resistance R_L = 25 Ω connected to V_{DD}; all specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 1.

Parameter	B Version[1] Min	B Version[1] Typ	B Version[1] Max	Unit	Test Conditions/Comments
DC PERFORMANCE					V_{DD} = 3.6 V to 4.5 V. Device operates over 2.7 V to 5.5 V with reduced performance.
Resolution		10		Bits	117 µA/LSB
Relative Accuracy[2]		±1.5	±4	LSB	
Differential Nonlinearity[2, 3]			±1	LSB	Guaranteed monotonic over all codes.
Zero Code Error[2, 4]	0	1	5	mA	All 0s loaded to DAC.
Offset Error @ Code 16[2]		0.5		mA	
Gain Error[2]			±0.6	% of FSR	@ 25°C
Offset Error Drift[4, 5]		10		µA/°C	
Gain Error Drift[2, 5]		±0.2	±0.5	LSB/°C	
OUTPUT CHARACTERISTICS					
Minimum Sink Current[4]		3		mA	
Maximum Sink Current		120		mA	V_{DD} = 3.6 V to 4.5 V. Device operates over 2.7 V to 5.5 V, but specified maximum sink current might not be achieved.
Output Current During PD		80		nA	PD = 1.
Output Compliance[5]	0.6		V_{DD}	V	Output voltage range over which max sink current is available.
Power-Up Time		20		µs	To 10% of FS, coming out of power-down mode. V_{DD} = 5 V.
LOGIC INPUTS (PD)[5]					
Input Current			±1	µA	
Input Low Voltage, V_{INL}			0.8	V	V_{DD} = 2.7 V to 5.5 V
Input High Voltage, V_{INH}	0.7 V_{DD}			V	V_{DD} = 2.7 V to 5.5 V
Pin Capacitance		3		pF	
LOGIC INPUTS (SCL, SDA)[5]					
Input Low Voltage, V_{INL}	−0.3		0.3 V_{DD}	V	
Input High Voltage, V_{INH}	0.7 V_{DD}		V_{DD} + 0.3	V	
Input Leakage Current I_{IN}			±1	µA	V_{IN} = 0 V to V_{DD}
Input Hysteresis, V_{HYST}	0.05 V_{DD}			V	
Digital Input Capacitance, C_{IN}		6		pF	
Glitch Rejection[6]			50	ns	Pulse width of spike suppressed.
POWER REQUIREMENTS					
V_{DD}	2.7		5.5	V	
I_{DD} (Normal Mode)					I_{DD} specification is valid for all DAC codes.
V_{DD} = 2.7 V to 5.5 V		2.5	4	mA	V_{IH} = V_{DD}, and V_{IL} = GND, V_{DD} = 5.5 V
V_{DD} = 2.7 V to 4.5 V		2.3	3	mA	V_{IH} = V_{DD}, and V_{IL} = GND, V_{DD} = 4.5 V
I_{DD} (Power-Down Mode)		0.5	1	µA	V_{IH} = V_{DD}, and V_{IL} = GND

[1] Temperature range is as follows: B Version: −40°C to +85°C.
[2] See the Terminology section.
[3] Linearity is tested using a reduced code range: Codes 32 to 1023.
[4] To achieve near zero output current, use the power-down feature.
[5] Guaranteed by design and characterization; not production tested.
[6] Input filtering on both the SCL and SDA inputs suppresses noise spikes that are less than 50 ns.

AC CHARACTERISTICS

V_{DD} = 2.7 V to 5.5 V, AGND = DGND = 0 V, load resistance R_L = 25 Ω connected to V_{DD}, unless otherwise noted.

Table 2.

Parameter	B Version[1, 2]			Unit	Test Conditions/Comments
	Min	Typ	Max		
Output Current Settling Time		250		µs	V_{DD} = 5 V, R_L = 25 Ω, L_L = 680 µH ¼ scale to ¾ scale change (0x100 to 0x300)
Slew Rate		0.3		mA/µs	
Major Code Change Glitch Impulse		0.15		nA-s	1 LSB change around major carry
Digital Feedthrough[3]		0.06		nA-s	

[1] Temperature range is as follows: B Version: −40°C to +85°C.
[2] Guaranteed by design and characterization; not production tested.
[3] See the Terminology section.

TIMING CHARACTERISTICS

V_{DD} = 2.7 V to 5.5 V. All specifications T_{MIN} to T_{MAX}, unless otherwise noted.

Table 3.

Parameter[1]	Limit at T_{MIN}, T_{MAX} (B Version)	Unit	Conditions/Comments
f_{SCL}	400	kHz max	SCL clock frequency
t_1	2.5	µs min	SCL cycle time
t_2	0.6	µs min	t_{HIGH}, SCL high time
t_3	1.3	µs min	t_{LOW}, SCL low time
t_4	0.6	µs min	$t_{HD,STA}$, start/repeated start condition hold time
t_5	100	ns min	$t_{SU,DAT}$, data setup time
t_6[2]	0.9	µs max	$t_{HD,DAT}$, data hold time
	0	µs min	
t_7	0.6	µs min	$t_{SU,STA}$, setup time for repeated start
t_8	0.6	µs min	$t_{SU,STO}$, stop condition setup time
t_9	1.3	µs min	t_{BUF}, bus free time between a stop condition and a start condition
t_{10}	300	ns max	t_R, rise time of both SCL and SDA when receiving
	0	ns min	May be CMOS driven
t_{11}	250	ns max	t_F, fall time of SDA when receiving
	300	ns max	t_F, fall time of Both SCL and SDA when transmitting
	20 + 0.1 C_b[3]	ns min	
C_b	400	pF max	Capacitive load for each bus line

[1] Guaranteed by design and characterization; not production tested.
[2] A master device must provide a hold time of at least 300 ns for the SDA signal (referred to the $V_{IH\ MIN}$ of the SCL signal) in order to bridge the undefined region of SCL's falling edge.
[3] C_b is the total capacitance of one bus line in pF. t_R and t_F are measured between 0.3 V_{DD} and 0.7 V_{DD}.
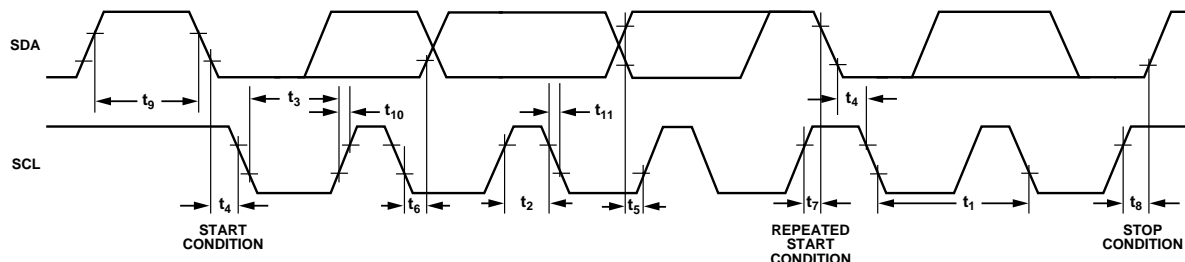

Figure 2. 2-Wire Serial Interface Timing Diagram

ABSOLUTE MAXIMUM RATINGS

$T_A = 25°C$, unless otherwise noted.[1]

Table 4.

Parameter	Rating
V_{DD} to AGND	−0.3 V to +7 V
V_{DD} to DGND	−0.3 V to V_{DD} + 0.3 V
AGND to DGND	−0.3 V to +0.3 V
SCL, SDA to DGND	−0.3 V to V_{DD} + 0.3 V
PD to DGND	−0.3 V to V_{DD} + 0.3 V
I_{SINK} to AGND	−0.3 V to V_{DD} + 0.3 V
Operating Temperature Range	
Industrial (B Version)	−40°C to +85°C
Storage Temperature Range	−65°C to +150°C
Junction Temperature (T_J max)	150°C
LFCSP Power Dissipation	$(T_J$ max − $T_A)/\theta_{JA}$
θ_{JA} Thermal Impedance[2]	
Mounted on 2-Layer Board	84°C/W
Mounted on 4-Layer Board	48°C/W
Lead Temperature, Soldering	
Vapor Phase (60 sec)	215°C
Infrared (15 sec)	220°C

[1] Transient currents of up to 100 mA do not cause SCR latch-up.
[2] To achieve the optimum θ_{JA}, it is recommended that the AD5398 is soldered on a 4-layer board. The AD5398 comes in an 8-lead LFCSP package with an exposed paddle that should be connected to the same potential as the AD5398 DGND pin.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those listed in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Only one absolute maximum rating may be applied at any one time.

ESD CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although this product features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.
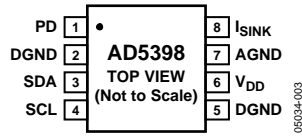
PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

Figure 3. 8-Lead LFCSP

Table 5.

Pin No.	Mnemonic	Description
1	PD	Power Down. Asynchronous power down signal.
2	DGND	Digital Ground Pin.
3	SDA	I²C Interface Signal.
4	SCL	I²C Interface Signal.
5	DGND	Digital Ground Pin.
6	V_{DD}	Digital Supply Voltage.
7	AGND	Analog Ground Pin.
8	I_{SINK}	Output Current Sink.

TYPICAL PERFORMANCE CHARACTERISTICS
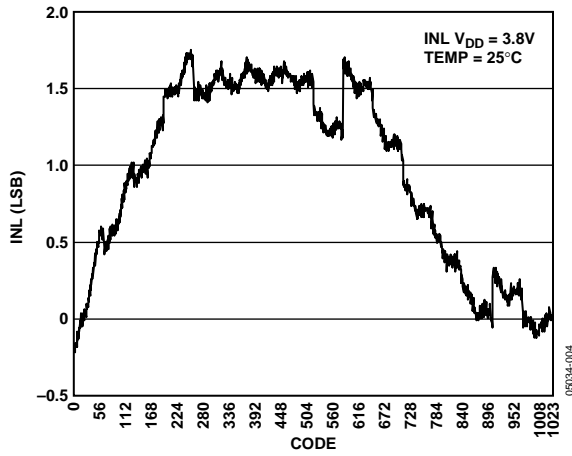
Figure 4. Typical INL Plot

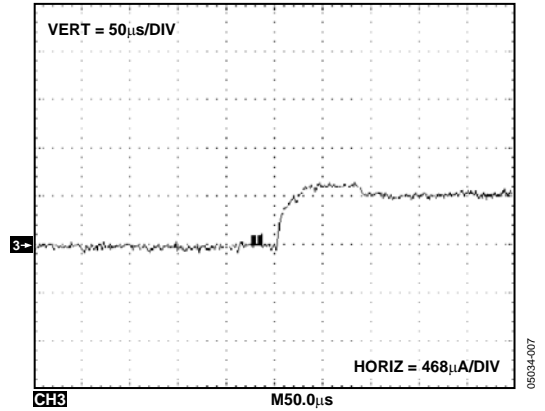Figure 5. Typical DNL Plot

Figure 6. ¼ to ¾ Scale Settling Time (V_{DD} = 3.6 V)

Figure 7. Settling Time for a 4-LSB Step (V_{DD} = 3.6 V)
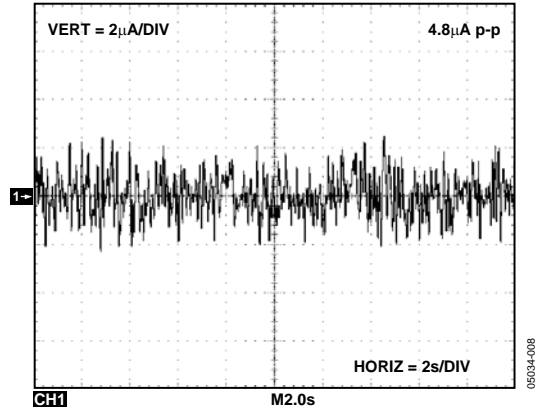
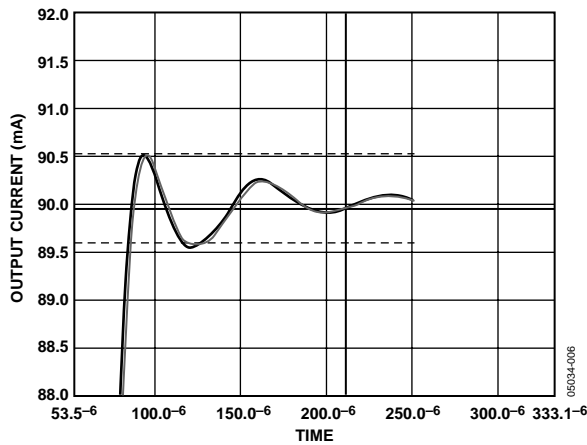
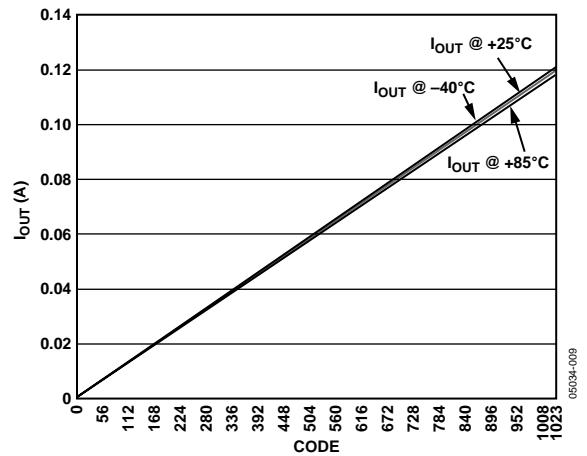Figure 8. 0.1 Hz to 10 Hz Noise Plot (V_{DD} = 3.6 V)

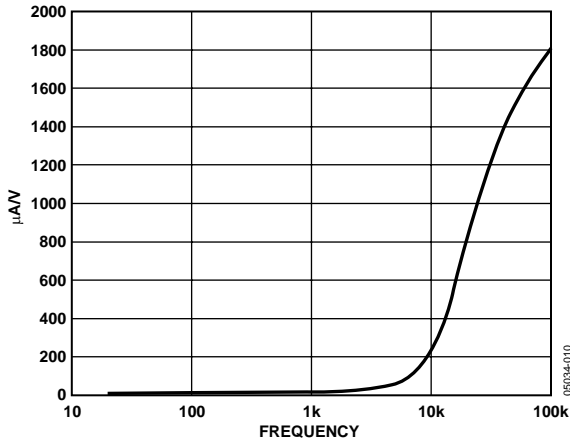Figure 9. Sink Current vs. Code vs. Temperature (V_{DD} = 3.6 V)

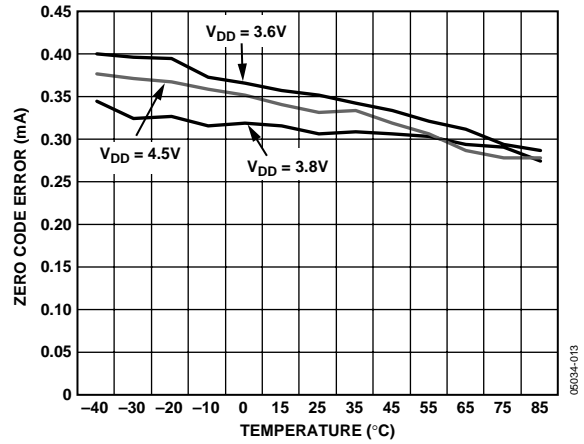Figure 10. AC Power Supply Rejection (V_{DD} = 3.6 V)

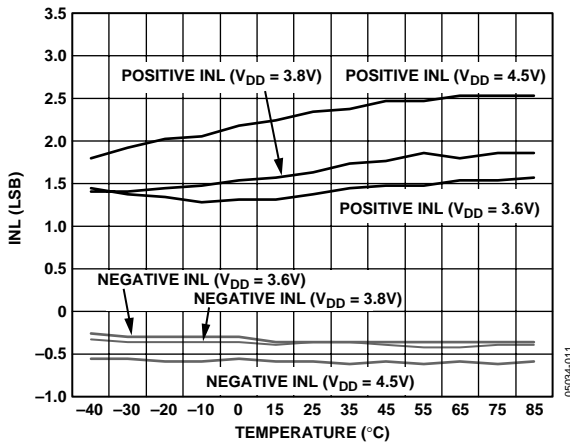Figure 13. Zero Code Error vs. Supply Voltage vs. Temperature
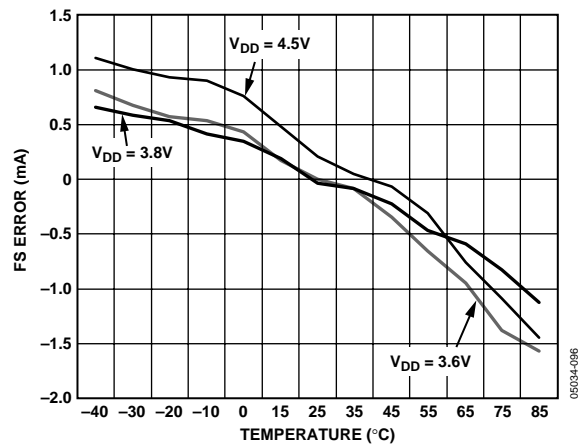

Figure 11. INL vs. Temperature vs. Supply

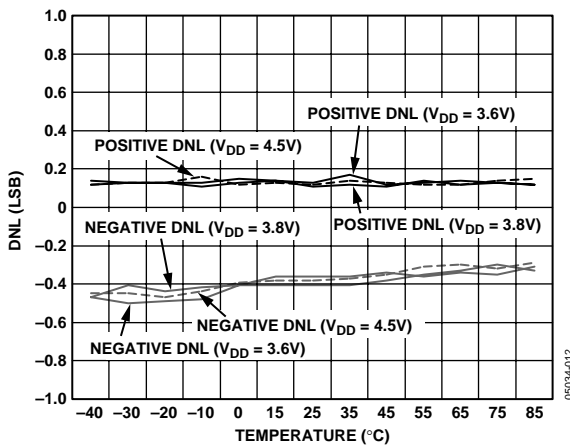Figure 14. Full-Scale Error vs. Temperature vs. Supply

Figure 12. DNL vs. Temperature vs. Supply

TERMINOLOGY

Relative Accuracy
For the DAC, relative accuracy or integral nonlinearity is a measurement of the maximum deviation, in LSBs, from a straight line passing through the endpoints of the DAC transfer function. A typical INL vs. code plot is shown in Figure 4.

Differential Nonlinearity (DNL)
Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of ±1 LSB maximum ensures monotonicity. This DAC is guaranteed monotonic by design. A typical DNL vs. code plot is shown in Figure 5.

Zero-Code Error
Zero-code error is a measurement of the output error when zero code (0x0000) is loaded to the DAC register. Ideally the output is 0 mA. The zero-code error is always positive in the AD5398 because the output of the DAC cannot go below 0 mA. This is due to a combination of the offset errors in the DAC and output amplifier. Zero-code error is expressed in mA.

Gain Error
This is a measurement of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from the ideal, expressed as a percent of the full-scale range.

Gain Error Drift
This is a measurement of the change in gain error with changes in temperature. It is expressed in LSB/°C.

Digital-to-Analog Glitch Impulse
Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is normally specified as the area of the glitch in nA-s and is measured when the digital input code is changed by 1 LSB at the major carry transition.

Digital Feedthrough
Digital feedthrough is a measurement of the impulse injected into the analog output of the DAC from the digital inputs of the DAC, but is measured when the DAC output is not updated. It is specified in nA-s and measured with a full-scale code change on the data bus, that is, from all 0s to all 1s and vice versa.

Offset Error
Offset error is a measurement of the difference between I_{SINK} (actual) and I_{OUT} (ideal) in the linear region of the transfer function, expressed in mA. Offset error is measured on the AD5398 with Code 16 loaded into the DAC register.

Offset Error Drift
This is a measurement of the change in offset error with a change in temperature. It is expressed in μV/°C.

THEORY OF OPERATION

The AD5398 is a fully integrated 10-bit DAC with 120 mA output current sink capability, and is intended for driving voice coil actuators in applications such as lens autofocus, image stabilization, and optical zoom. The circuit diagram is shown in Figure 15. A 10-bit current output DAC coupled with Resistor R generates the voltage that drives the noninverting input of the operational amplifier. This voltage also appears across the R_{SENSE} resistor, and generates the sink current required to drive the voice coil.

Resistors R and R_{SENSE} are interleaved and matched, and therefore the temperature coefficient and any nonlinearities over temperature are matched and the output drift over temperature is minimized. Diode D1 is an output protection diode.
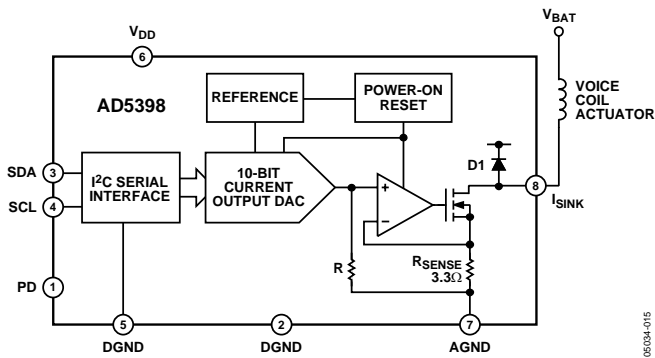

Figure 15. Block Diagram Showing Connection to Voice Coil

SERIAL INTERFACE

The AD5398 is controlled using the industry-standard I²C 2-wire serial protocol. Data can be written to the DAC, or read back from it, at data rates up to 400 kHz. After a read operation the contents of the input register are reset to all zeros.

I²C BUS OPERATION

An I²C bus operates with one or more master devices that generate the serial clock (SCL), and read/write data on the serial data line (SDA) to/from slave devices such as the AD5398. All devices on an I²C bus have their SCL pin connected to the SDA line, and their SCL pin connected to the SCL line. I²C devices can only pull the bus lines low; pulling high is achieved by pull-up resistors R_P. The value of R_P depends on the data rate, bus capacitance, and the maximum load current that the I²C device can sink (3 mA for a standard device).
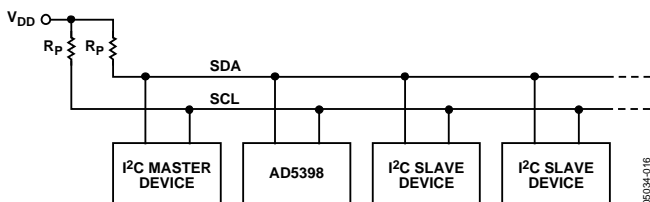

Figure 16. Typical I²C Bus

When the bus is idle, SCL and SDA are both high. The master device initiates a serial bus operation by generating a start condition, which is defined as a high-to-low transition on the SDA low while SCL is high. The slave device connected to the bus responds to the start condition, and shifts in the next 8 data bits under control of the serial clock. These 8 data bits consist of a 7-bit address, plus a read/write bit, which is 0 if data is to be written to a device, and 1 if data is to be read from a device. Each slave device on an I²C bus must have a unique address. The address of the AD5398 is 0001 100, however, 0001101, 0001110, and 0001111 address the part because the last two bits are unused/don't care (see Figure 17 and Figure 18). Since the address plus R/W bit always equals 8 bits of data, another way of looking at it is that the write address of the AD5398 is 0001 1000 (0x18) and the read address is 0001 1001 (0x19). Again, Bit 6 and Bit 7 of the address are unused, and therefore the write addresses can also be 0x1A, 0x1C, and 0x1E, and the read address can be 0x1B, 0x1D, and 0x1F (see Figure 17 and Figure 18).

At the end of the address data, after the R/W bit, the slave device that recognizes its own address responds by generating an acknowledge (ACK) condition. This is defined as the slave device pulling SDA low while SCL is low before the ninth clock pulse, and keeping it low during the ninth clock pulse. Upon receiving ACK, the master device can clock data into the AD5398 in a write operation, or it can clock it out in a read operation. Data must change only during the low period of the clock, because SDA transitions during the high period define a start condition as described previously, or a stop condition as described in the Data Format section.

I²C data is divided into blocks of 8 bits, and the slave generates an ACK at the end of each block. Since the AD5398 requires 10 bits of data, two data-words must be written to it when a write operation, or read back from it when a read operation. At the end of a read or write operation, the AD5398 acknowledges the second data byte. The master generates a stop condition, defined as a low-to-high transition on SDA while SCL is high, to end the transaction.

DATA FORMAT

Data is written to the AD5398 high byte first, MSB first, and is shifted into the 16-bit input register. After all data is shifted in, data from the input register is transferred to the DAC register.

Because the DAC requires only 10 bits of data, not all bits of the input register data are used. The MSB is reserved for an active-high, software-controlled, power-down function. Bit 14 is unused; Bits 13 to 4 are DAC data; Bits 9 to 0 and Bits 3 to 0 are unused.

During a read operation, data is read back in the same bit order.
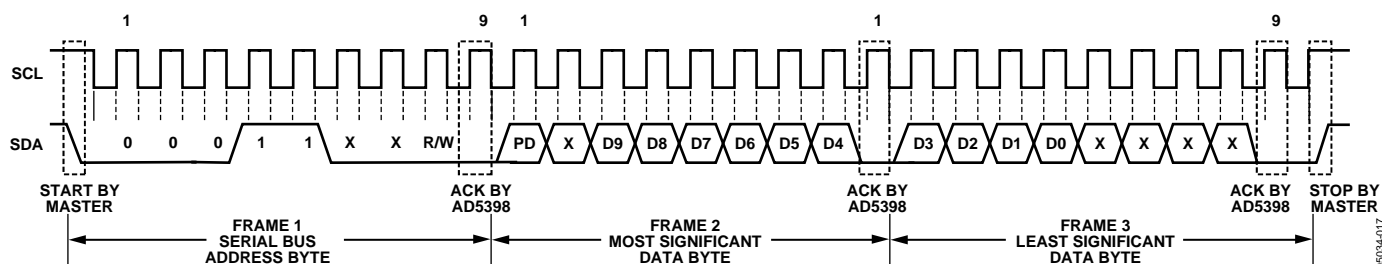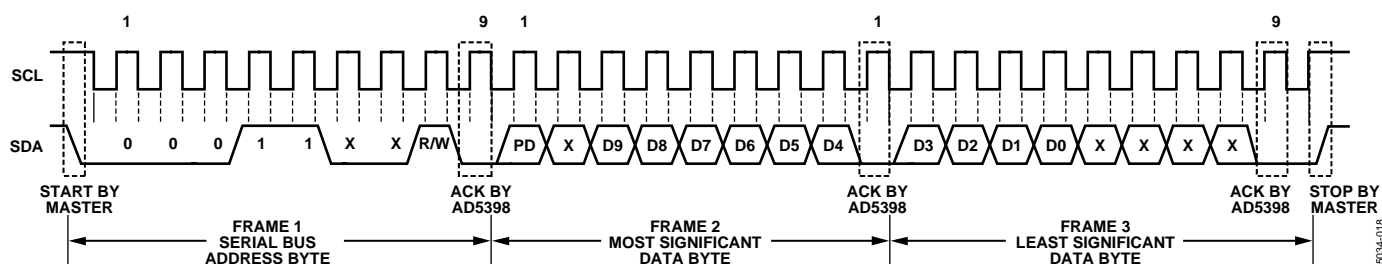
Figure 17. AD5398 Write Operation

Figure 18. AD5398 Read Operation

Table 6. Data Format

Serial Data Words	High Byte								Low Byte							
Serial Data Bits	SD7	SD6	SD5	SD4	SD3	SD2	SD1	SD0	SD7	SD6	SD5	SD4	SD3	SD2	SD1	SD0
Input Register	R15	R14	R13	R12	R11	R10	R9	R8	R7	R6	R5	R4	R3	R2	R1	R0
Function	PD	X	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	X	X	X	X

PD = soft power-down; X = unused/don't care; D9 to D0 = DAC data

POWER SUPPLY BYPASSING AND GROUNDING

When accuracy is important in an application, it is beneficial to consider power supply and ground return layout on the PCB. The PCB for the AD5398 should have separate analog and digital power supply sections. Where shared AGND and DGND is necessary, the connection of grounds should be made at only one point, as close as possible to the AD5398.

Special attention should be paid to the layout of the AGND return path and track between the voice coil motor and I_{SINK} to minimize any series resistance. Figure 19 shows the output current sink of the AD5398, and illustrates the importance of reducing the effective series impedance of AGND, and the track resistance between the motor and I_{SINK}. The voice coil is modeled as inductor L_C and resistor R_C. The current through the voice coil is effectively a dc current which results in a voltage drop, V_C, when the AD5398 is sinking current; the effect of any series inductance is minimal. The maximum voltage drop allowed across R_{SENSE} is 400 mV, and the minimum drain to source voltage of Q1 is 200 mV. This means that the AD5398 output has a compliance voltage of 600 mV. If V_{DROP} falls below 600 mV, the output transistor, Q1, can no longer operate properly and I_{SINK} might not be maintained as a constant.
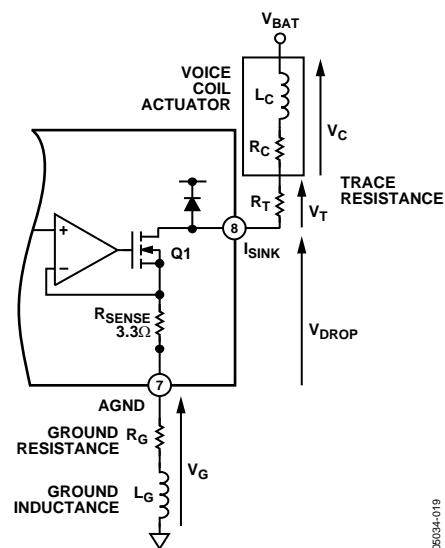

Figure 19. Effect of PCB Trace Resistance and Inductance

As the current increases through the voice coil, V_C increases and V_{DROP} decreases and eventually approaches the minimum specified compliance voltage of 600 mV. The ground return path is modeled by the components R_G and L_G, and the track resistance between the voice coil and the AD5398 is modeled as R_T. The inductive effects of L_G influence R_{SENSE} and R_C equally and, because the current is maintained as a constant, it is not as critical as the purely resistive component of the ground return path. When the maximum sink current is flowing through the motor the resistive elements, R_T and R_G, might have an impact on the voltage headroom of Q1, and could, in turn, limit the maximum value of R_C because of voltage compliance.

For example,

V_{BAT} = 3.6 V

R_G = 0.5 Ω

R_T = 0.5 Ω

I_{SINK} = 120 mA

V_{DROP} = 600 mV (the compliance voltage)

Then the largest value of resistance of the voice coil, R_C, is

$$R_C = \frac{V_{BAT} - [V_{DROP} + (I_{SINK} \times R_T) + (I_{SINK} \times R_G)]}{I_{SINK}} =$$

$$\frac{3.6 \text{ V} - [600 \text{ mV} + 2 \times (120 \text{ mA} \times 0.5 \text{ Ω})]}{120 \text{ mA}} = 24 \text{ Ω}$$

For this reason it is important to minimize any series impedance on both the ground return path and interconnect between the AD5398 and the motor.

The power supply of the AD5398 should be decoupled with 0.1 µF and 10 µF capacitors. These capacitors should be kept as physically close as possible, with the 0.1 µF capacitor serving as a local bypass capacitor, and therefore should be located as close as possible to the V_{DD} pin. The 10 µF capacitor should be a tantalum bead-type; the 0.1 µF capacitor should be a ceramic type with a low effective series resistance and effective series inductance. The 0.1 µF capacitor provides a low impedance path to ground for high transient currents.

The power supply line itself should have as large a trace as possible to provide a low impedance path and reduce glitch effects on the supply line. Clocks and other fast switching digital signals should be shielded from other parts of the board by digital ground. Avoid crossover of digital and analog signals if possible. When traces cross on opposite sides of the board, ensure that they run at right angles to each other to reduce feedthrough effects through the board. The best board layout technique is to use a multilayer board with ground and power planes, where the component side of the board is dedicated to the ground plane only and the signal traces are placed on the solder side. However, this is not always possible with a 2-layer board.

The exposed paddle on the AD5398 should be soldered to ground to ensure the best possible thermal performance. The thermal impedance of the AD5398 LFCSP package is 48°C/W when soldered in a 4-layer board. It is defined in the Absolute Maximum Ratings.

APPLICATIONS

The AD5398 is designed to drive both spring preloaded and nonspring linear motors used in applications such as lens auto-focus, image stabilization, or optical zoom. The operation principle of the spring preloaded motor is that the lens position is controlled by the balancing of a voice coil and spring. Figure 20 shows the transfer curve of a typical spring preloaded linear motor for autofocus. The key points of this transfer function are displacement or stroke, which is the actual distance the lens moves in mm, and the current through the motor in mA.
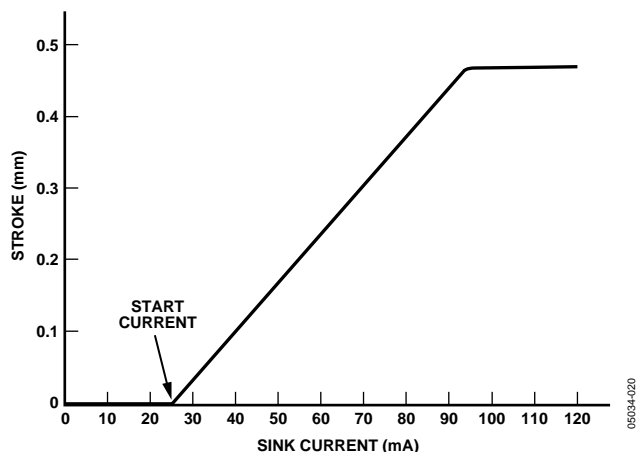
Figure 20. Spring Preloaded Voice Coil Stroke vs. Sink Current

A start current is associated with spring preloaded linear motors, which is effectively a threshold current that must be exceeded for any displacement in the lens to occur. The start current is usually 20 mA or greater; the rated stroke or displacement is usually 0.25 mm to 0.4 mm; and the slope of the transfer curve is approximately 10 μm/mA or less.

Figure 21 shows the transfer curve for a linear motor, which does not include a spring. The primary difference between this type of motor and the spring preload motor is the absence of the start current. Because no spring is used, displacement occurs when current is applied.

The AD5398 is designed to sink up to 120 mA, which is more than adequate for available commercial linear motors or voice coils. Another factor that makes the AD5398 the ideal solution for these applications is the monotonicity of the device, which ensures that lens positioning is repeatable for the application of a given digital word.
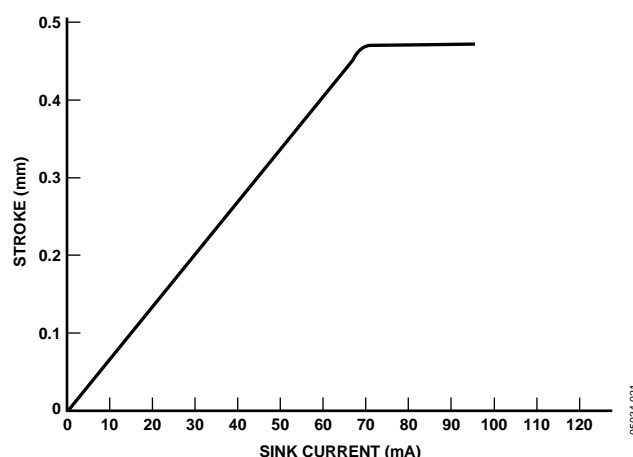

Figure 21. Nonspring Voice Coil Stroke vs. Sink Current

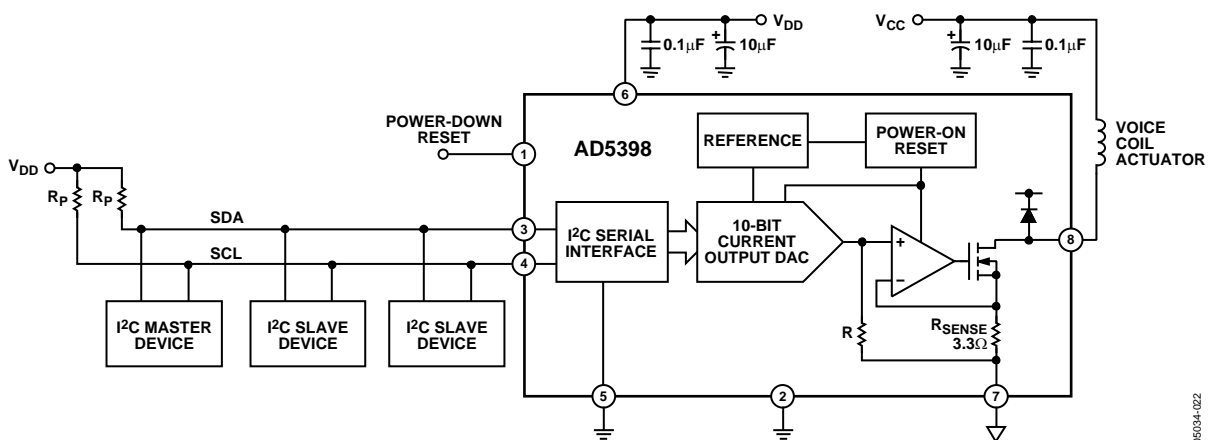Figure 22 shows a typical application circuit for the AD5398.

Figure 22. Typical Application Circuit
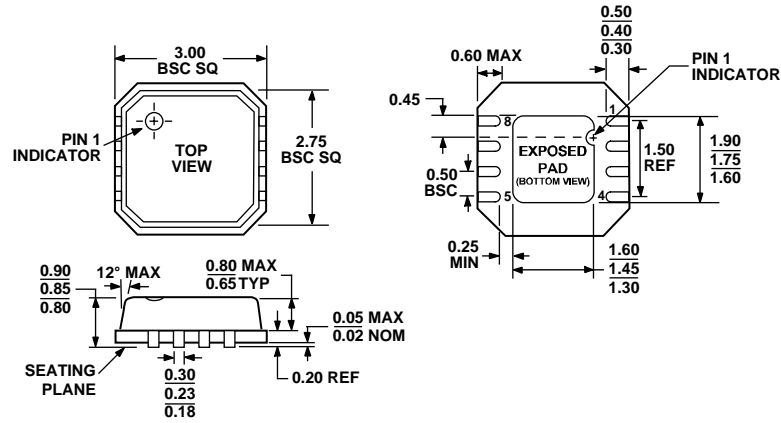
AD5398

OUTLINE DIMENSIONS

Figure 23. 8-Lead Lead Frame Chip Scale Package [VD_LFCSP]
3 mm × 3 mm Body, Very Thin, Dual Lead
(CP-8-2)
Dimensions shown in millimeters

ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option
AD5398BCPZ-REEL[1]	−40°C to +85°C	8-lead VD_LFCSP	CP-8-2
AD5398BCPZ-REEL7[1]	−40°C to +85°C	8-lead VD_LFCSP	CP-8-2
AD5398BCPZ-WP[1]	−40°C to +85°C	8-lead VD_LFCSP	CP-8-2

[1] Z = Pb-free part.

NOTES

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